## Notice of References Cited Application/Control No. 10/811,985 Examiner John T. Kwon Applicant(s)/Patent Under Reexamination TANIKAWA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0172894 A1	09-2003	Iwata et al.	123/184.42
	В	US-2004/0194750 A1	10-2004	Tanikawa et al.	123/184.42
	С	US-6,805,088 B2	10-2004	Tachibana et al.	123/184.47
	D	US-2004/0261745 A1	12-2004	Kito et al.	123/184.42
	Е	US-6,857,409 B2	02-2005	Ito et al.	123/184.42
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	M	US-			

## FOREIGN PATENT DOCUMENTS

*.		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0	•				
	Р					
	D	(4)				
	R		·			
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.